

<b>Notice of References Cited</b>	Application/Control No. 10/584,379		Applicant(s)/Patent Under Reexamination BEST ET AL.	
	Examiner /Laura S. Weiner/		Art Unit 1726	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,551,744	04-2003	Ohzuku et al.	429/223
*	B	US-6,514,640	02-2003	Armand et al.	429/231.1
*	C	US-6,465,129	10-2002	Xu et al.	429/224
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

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